	FCC Test Report
Report No.:	RF190705C23
FCC ID:	LDKHS7302077
Test Model:	HS-WL-730
Received Date:	Jul. 05, 2019
Test Date:	Oct. 01, 2019 ~ Oct. 09, 2019
Issued Date:	Oct. 21, 2019
Applicant:	CISCO SYSTEMS INC
Address:	170 W TASMAN DR, SAN JOSE, CA, 95134, USA
Issued By:	Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch
	Lin Kou Laboratories
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Test Location:	No.19, Hwa Ya 2nd Rd., Wen Hwa Vil., Kwei Shan Dist., Taoyuan City 33383, Taiwan
FCC Registration /	788550 / TW0003
Designation Number:	7003307 100003
	Testing Laboratory
	2021

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Release Control Record Issue No. Description Date Issued Original Release Oct. 21, 2019 RF190705C23



Certificate of Conformity 1

Product:	Headset
Brand:	CISCO
Test Model:	HS-WL-730
Sample Status:	Engineering Sample
Applicant:	CISCO SYSTEMS INC
Test Date:	Oct. 01, 2019 ~ Oct. 09, 2019
Standards:	47 CFR FCC Part 15, Subpart C (Section 15.247)
	ANSI C63.10:2013

The above equipment has been tested by Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's RF characteristics under the conditions specified in this report.

Prepared by :

hen ona

Rona Chen / Specialist

Date:

Oct. 21, 2019

Approved by :

Rihi 1

Date: Oct. 21, 2019

Dylan Chiou / Project Engineer



2 Summary of Test Results

47 CFR FCC Part 15, Subpart C (Section 15.247)								
FCC Clause	Test Item	Result	Remarks					
15.207	207 AC Power Conducted Emission		Meet the requirement of limit. Minimum passing margin is -18.65 dB at 0.41560 MHz.					
15.247(a)(1) (iii)	Number of Hopping Frequency Used	Pass	Meet the requirement of limit.					
15.247(a)(1) (iii)	Dwell Time on Each Channel	Pass	Meet the requirement of limit.					
15.247(a)(1)	.247(a)(1) 1. Hopping Channel Separation 2. Spectrum Bandwidth of a Frequency Hopping Sequence Spread Spectrum System		Meet the requirement of limit.					
15.247(a)(1)	15.247(a)(1) Maximum Peak Output Power		Meet the requirement of limit.					
	Occupied Bandwidth Measurement	Pass	Reference only					
15.205 & 209	15.205 & 209 Radiated Emissions Pas		Meet the requirement of limit. Minimum passing margin is -3.96 dB at 76.56 MHz.					
15.247(d) Band Edge Measurement		Pass	Meet the requirement of limit.					
15.247(d)	Antenna Port Emission	Pass	Meet the requirement of limit.					
15.203	Antenna Requirement	Pass	Antenna connector is i-pex (MHF) not a standard connector.					

Note:

1. If the Frequency Hopping System operating in 2400-2483.5 MHz band and the output power less than 125 mW. The hopping channel carrier frequencies separated by a minimum of 25 kHz or two-thirds of the 20 dB bandwidth of hopping channel whichever is greater.

2. Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Measurement Frequency		
Conducted Emissions at mains ports	150 kHz ~ 30 MHz	2.94 dB	
	9 kHz ~ 30 MHz	3.04 dB	
Radiated Emissions up to 1 GHz	30 MHz ~ 200 MHz	2.93 dB	
	200 MHz ~ 1000 MHz	2.95 dB	
Radiated Emissions above 1 GHz	1 GHz ~ 18 GHz	2.26 dB	
	18 GHz ~ 40 GHz	1.94 dB	

2.2 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 General Description of EUT

Product	Headset
Brand	CISCO
Test Model	HS-WL-730
Status of EUT	Engineering Sample
Dower Supply Doting	5.0 Vdc (Host equipment)
Power Supply Rating	3.7 Vdc (Battery)
Modulation Type	GFSK, π/4-DQPSK, 8DPSK
Transfer Rate	1/2/3 Mbps
Operating Frequency	2402 ~ 2480 MHz
Number of Channel	79
Output Power	4.487 mW
Antenna Type	PIFA antenna with 3.64 dBi gain
Antenna Connector	i-pex (MHF)
Accessory Device	Refer to Note as below
Data Cable Supplied	Refer to Note as below

Note:

1. The EUT contains following accessory devices.

Product Brand		Product Brand Model	
Battery Pack	Battery Pack Synergy		3.7Vdc, 500mAh
USB Cable	USB Cable N/A		1.27m length cable
3.5mm Audio Cable	N/A	74-123494	1.27m length cable

2. The above EUT information is declared by manufacturer and for more detailed features description, please refers to the manufacturer's specifications or User's Manual.



3.2 Description of Test Modes

79 channels are provided to this EUT:

Channel	Freq. (MHz)						
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461		



3.2.1 Test Mode Applicability and Tested Channel Detail

EUT Configu	e	Applicable To			Description
Mode	RE≥1G	RE<1G	PLC	APCM	Description
-	\checkmark	\checkmark	\checkmark	\checkmark	-
Where	Where RE≥1G: Radiated Emission above 1 GHz RE <				adiated Emission below 1 GHz
I	LC: Power Line Conducted Emission APCM: A			APCM: Ant	enna Port Conducted Measurement

Note: The EUT had been pre-tested on the positioned of X and Z axis. The worst case was found when positioned on **Z-plane**.

Radiated Emission Test (Above 1 GHz):

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
 Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
-	0 to 78	0, 39, 78	FHSS	GFSK	DH5
	0 to 78	0, 39, 78	FHSS	8DPSK	3DH5

Radiated Emission Test (Below 1 GHz):

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
 Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
-	0 to 78	78	FHSS	8DPSK	3DH5

Power Line Conducted Emission Test:

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
 Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
-	0 to 78	78	FHSS	8DPSK	3DH5



Antenna Port Conducted Measurement:

- This item includes all test value of each mode, but only includes spectrum plot of worst value of each mode.
- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
 Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
-	0 to 78	0, 39, 78	FHSS	GFSK	DH5
-	0 to 78	0, 39, 78	FHSS	8DPSK	3DH5

Test Condition:

Applicable To	Environmental Conditions	Environmental Conditions Input Power	
RE≥1G	25 deg. C, 65 % RH	120 Vac, 60 Hz	Tim Chen
RE<1G	25 deg. C, 65 % RH	120 Vac, 60 Hz	Tim Chen
PLC	25 deg. C, 65 % RH	120 Vac, 60 Hz	Getaz Yang
APCM	25 deg. C, 65 % RH	5.0 Vdc	Wayne Lin



3.3 Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

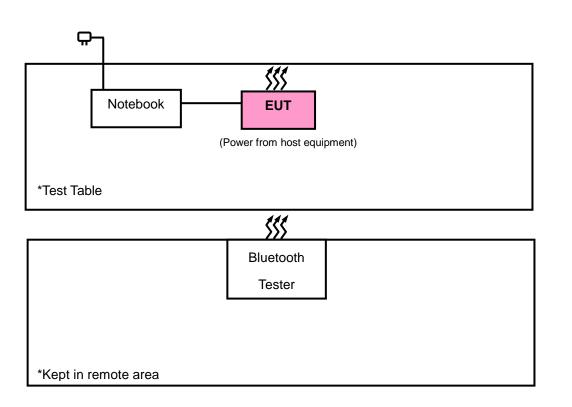
No.	Product	Brand	Model No.	Serial No.	FCC ID
1.	Notebook	DELL	E5420	8BHF5S1	N/A

No.	Signal Cable Description Of The Above Support Units
1.	N/A

Note:

1. All power cords of the above support units are non-shielded (1.8m).

3.3.1 Configuration of System under Test



3.4 General Description of Applied Standards

The EUT is a RF Product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

FCC Part 15, Subpart C (15.247) KDB 558074 D01 15.247 Meas Guidance v05r02 ANSI C63.10-2013

All test items have been performed and recorded as per the above standards.



4 Test Types and Results

4.1 Radiated Emission and Bandedge Measurement

4.1.1 Limits of Radiated Emission and Bandedge Measurement

Radiated emissions which fall in the restricted bands must comply with the radiated emission limits specified as below table. Other emissions shall be at least 20 dB below the highest level of the desired power:

Frequencies (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meters)
0.009 ~ 0.490	2400/F (kHz)	300
0.490 ~ 1.705	24000/F (kHz)	30
1.705 ~ 30.0	30	30
30 ~ 88	100	3
88 ~ 216	150	3
216 ~ 960	200	3
Above 960	500	3

Note:

- a. The lower limit shall apply at the transition frequencies.
- b. Emission level (dBuV/m) = 20 log Emission level (uV/m).
- c. For frequencies above 1000 MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20 dB under any condition of modulation.



4.1.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Date of Calibration	Due Date of Calibration
Test Receiver Agilent	N9038A	MY51210203	Mar. 18, 2019	Mar. 17, 2020
Spectrum Analyzer Agilent	N9010A	MY52220314	Dec. 13, 2018	Dec. 12, 2019
Spectrum Analyzer ROHDE & SCHWARZ	FSU43	101261	Apr. 15, 2019	Apr. 14, 2020
Broadband Horn Antenna SCHWARZBECK	BBHA 9170	148	Nov. 25, 2018	Nov. 24, 2019
HORN Antenna SCHWARZBECK	BBHA 9120D	9120D-969	Nov. 25, 2018	Nov. 24, 2019
BILOG Antenna SCHWARZBECK	VULB 9168	9168-472	Nov. 23, 2018	Nov. 22, 2019
Fixed Attenuator WOKEN	MDCS18N-10	MDCS18N-10-01	Apr. 15, 2019	Apr. 14, 2020
Loop Antenna	EM-6879	269	Sep. 16, 2019	Sep. 15, 2020
Bluetooth Tester	CBT	100946	Aug. 09, 2018	Aug. 08, 2020
Preamplifier EMCI	EMC001340	980201	Oct. 12, 2018	Oct. 11, 2019
Preamplifier EMCI	EMC 012645	980115	Oct. 12, 2018	Oct. 11, 2019
Preamplifier EMCI	EMC 184045	980116	Oct. 12, 2018	Oct. 11, 2019
Preamplifier EMCI	EMC 330H	980112	Oct. 12, 2018	Oct. 11, 2019
Power Meter Anritsu	ML2495A	1012010	Sep. 04, 2019	Sep. 03, 2020
Power Sensor Anritsu	MA2411B	1315050	Sep. 04, 2019	Sep. 03, 2020
RF Coaxial Cable HUBER+SUHNNER	EMC104-SM-SM-8 000&3000	140811+170717	Oct. 12, 2018	Oct. 11, 2019
RF Coaxial Cable HUBER+SUHNNER	SUCOFLEX 104	EMC104-SM-SM-1 000(140807)	Oct. 12, 2018	Oct. 11, 2019
RF Coaxial Cable WOKEN	8D-FB	Cable-Ch10-01	Oct. 12, 2018	Oct. 11, 2019
Software BV ADT	E3 6.120103	NA	NA	NA
Antenna Tower MF	MFA-440H	NA	NA	NA
Turn Table MF	MFT-201SS	NA	NA	NA
Antenna Tower &Turn Table Controller MF	MF-7802	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 / 24 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Chamber 10.



4.1.3 Test Procedures

For Radiated Emission below 30 MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. Parallel, perpendicular, and ground-parallel orientations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Quasi-Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

Note:

1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 9 kHz at frequency below 30 MHz.

For Radiated Emission above 30 MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters (for 30 MHz ~ 1 GHz) / 1.5 meters (for above 1 GHz) above the ground at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.
- f. The test-receiver system was set to peak and average detected function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz. If the peak reading value also meets average limit, measurement with the average detector is unnecessary.

Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 kHz for Quasi-peak detection (QP) or Peak detection (PK) at frequency below 1 GHz.
- 2. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 3 MHz for Peak detection (PK) at frequency above 1 GHz.
- The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is ≥ 1/T (Duty cycle < 98 %) or 10 Hz (Duty cycle ≥ 98 %) for Average detection (AV) at frequency above 1 GHz. (RBW = 1 MHz, VBW = 1 kHz)
- 4. All modes of operation were investigated and the worst-case emissions are reported.

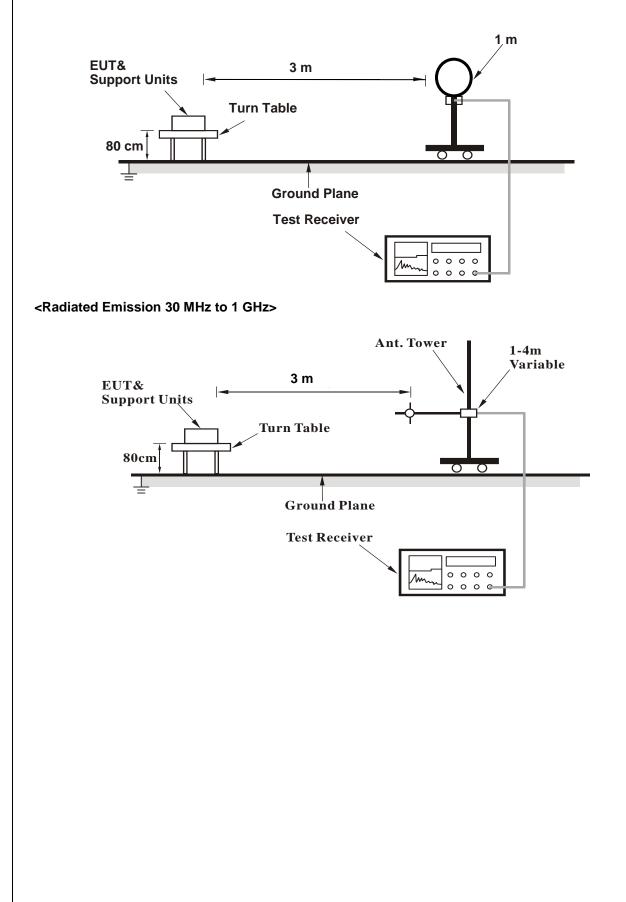
4.1.4 Deviation from Test Standard

No deviation.

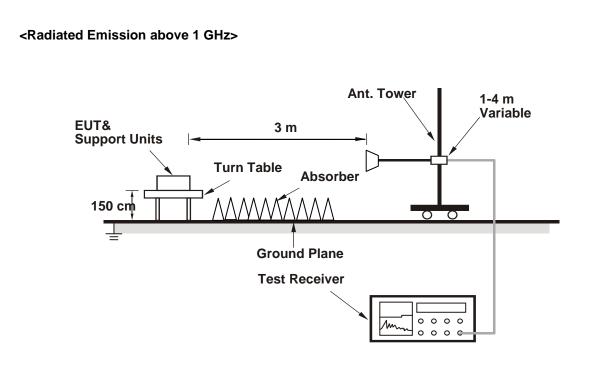


4.1.5 Test Set Up

<Radiated Emission below 30 MHz>







For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.1.6 EUT Operating Conditions

Set the EUT under transmission condition continuously at specific channel frequency.



4.1.7 Test Results

Above 1 GHz Data:

GFSK

EUT Test Condition		Measurement Detail		
Channel	Channel 0	Frequency Range	1 GHz ~ 25 GHz	
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Average (AV)	
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Tim Chen	

	Antenna Polarity & Test Distance: Horizontal at 3 m							
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2390	46.65	51.65	-5	54	-7.35	363	299	Average
2390	48.32	53.32	-5	74	-25.68	363	299	Peak
2402	99.14	104.14	-5			363	299	Average
2402	99.68	104.68	-5			363	299	Peak
4804	39.06	53.53	-14.47	54	-14.94	100	137	Average
4804	47.68	62.15	-14.47	74	-26.32	100	137	Peak
		Antenna	a Polarity 8	Test Dista	nce: Vertica	l at 3 m		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2390	44.99	49.99	-5	54	-9.01	119	93	Average
2390	48.56	53.56	-5	74	-25.44	119	93	Peak
2402	99.29	104.29	-5			119	93	Average
2402	99.9	104.9	-5			119	93	Peak
4804	38.03	52.5	-14.47	54	-15.97	100	296	Average
4804	47.32	61.79	-14.47	74	-26.68	100	296	Peak

Remarks:

1. Emission Level = Read Level + Factor

Margin value = Emission level – Limit value

2. 2402 MHz: Fundamental frequency.

3. The emission levels of other frequencies were very low against the limit.



EUT Test Condition		Measurement Detail		
Channel	Channel 39	Frequency Range	1 GHz ~ 25 GHz	
Input Power	120 Vac, 60 Hz		Peak (PK) Average (AV)	
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Tim Chen	

	Antenna Polarity & Test Distance: Horizontal at 3 m							
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
2441	99.63	104.54	-4.91			165	263	Average
2441	100.08	104.99	-4.91			165	263	Peak
4882	40.2	54.28	-14.08	54	-13.8	108	13	Average
4882	47.91	61.99	-14.08	74	-26.09	108	13	Peak
7323	44.75	51.45	-6.7	54	-9.25	353	205	Average
7323	53.68	60.38	-6.7	74	-20.32	353	205	Peak
		Antenna	a Polarity &	Test Dista	nce: Vertica	l at 3 m		
Frequency (MHz)	Frequency Level Read Level Factor Limit Margin (dB) Antenna Table Angle Rema						Remark	
2441	99.76	104.67	-4.91			100	86	Average
2441	100.36	105.27	-4.91			100	86	Peak
4882	39.42	53.5	-14.08	54	-14.58	100	88	Average
4882	46.22	60.3	-14.08	74	-27.78	100	88	Peak

Remarks:

- Emission Level = Read Level + Factor Margin value = Emission level – Limit value
- 2. 2441 MHz: Fundamental frequency.
- 3. The emission levels of other frequencies were very low against the limit.



EUT Test Condition		Measurement Detail		
Channel	Channel 78	Frequency Range	1 GHz ~ 25 GHz	
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Average (AV)	
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Tim Chen	

	Antenna Polarity & Test Distance: Horizontal at 3 m								
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark	
2480	98.77	103.62	-4.85			118	265	Average	
2480	99.36	104.21	-4.85			118	265	Peak	
2483.5	47.27	52.12	-4.85	54	-6.73	118	265	Average	
2483.5	48.03	52.88	-4.85	74	-25.97	118	265	Peak	
4960	38.25	52.14	-13.89	54	-15.75	100	135	Average	
4960	46.87	60.76	-13.89	74	-27.13	100	135	Peak	
		Antenn	a Polarity &	Test Dista	nce: Vertica	l at 3 m			
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark	
2480	98.89	103.74	-4.85			100	85	Average	
2480	99.43	104.28	-4.85			100	85	Peak	
2483.5	47.12	51.97	-4.85	54	-6.88	100	85	Average	
2483.5	48.8	53.65	-4.85	74	-25.2	100	85	Peak	
4960	38.21	52.1	-13.89	54	-15.79	100	135	Average	
4960	47.34	61.23	-13.89	74	-26.66	100	135	Peak	

Remarks:

 Emission Level = Read Level + Factor Margin value = Emission level – Limit value

2. 2480 MHz: Fundamental frequency.

3. The emission levels of other frequencies were very low against the limit.



8DPSK

EUT Test Condition		Measurement Detail					
Channel	Channel 0	Frequency Range	1 GHz ~ 25 GHz				
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Average (AV)				
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Tim Chen				

	Antenna Polarity & Test Distance: Horizontal at 3 m									
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark		
2390	47.02	52.02	-5	54	-6.98	261	260	Average		
2390	49.27	54.27	-5	74	-24.73	261	260	Peak		
2402	97.61	102.61	-5			261	260	Average		
2402	99.98	104.98	-5			261	260	Peak		
4804	35.65	50.12	-14.47	54	-18.35	112	296	Average		
4804	45.3	59.77	-14.47	74	-28.7	112	296	Peak		
		Antenna	a Polarity 8	Test Dista	nce: Vertica	l at 3 m				
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark		
2390	47.53	52.53	-5	54	-6.47	120	86	Average		
2390	48.97	53.97	-5	74	-25.03	120	86	Peak		
2402	97.02	102.02	-5			124	86	Average		
2402	100.03	105.03	-5			124	86	Peak		
4804	38.1	52.57	-14.47	54	-15.9	100	125	Average		
4804	47.15	61.62	-14.47	74	-26.85	100	125	Peak		

Remarks:

- Emission Level = Read Level + Factor Margin value = Emission level – Limit value
- 2. 2402 MHz: Fundamental frequency.
- 3. The emission levels of other frequencies were very low against the limit.



EUT Test Condition		Measurement Detail		
Channel	Channel 39	Frequency Range	1 GHz ~ 25 GHz	
Input Power	120 Vac, 60 Hz		Peak (PK) Average (AV)	
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Tim Chen	

	Antenna Polarity & Test Distance: Horizontal at 3 m								
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark	
2441	98.28	103.19	-4.91			163	266	Average	
2441	101.48	106.39	-4.91			163	266	Peak	
4882	37.28	51.36	-14.08	54	-16.72	103	125	Average	
4882	45.55	59.63	-14.08	74	-28.45	103	125	Peak	
		Antenna	a Polarity &	Test Dista	nce: Vertica	l at 3 m			
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark	
2441	97.49	102.4	-4.91			100	90	Average	
2441	100.35	105.26	-4.91			100	90	Peak	
4882	38.33	52.41	-14.08	54	-15.67	100	293	Average	
4882	46.78	60.86	-14.08	74	-27.22	100	293	Peak	

Remarks:

1. Emission Level = Read Level + Factor

Margin value = Emission level - Limit value

- 2. 2441 MHz: Fundamental frequency.
- 3. The emission levels of other frequencies were very low against the limit.



EUT Test Condition		Measurement Detail		
Channel	Channel 78	Frequency Range	1 GHz ~ 25 GHz	
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Average (AV)	
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Tim Chen	

	Antenna Polarity & Test Distance: Horizontal at 3 m									
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark		
2480	98.28	103.13	-4.85			123	264	Average		
2480	101.29	106.14	-4.85			123	264	Peak		
2483.5	49.19	54.04	-4.85	54	-4.81	123	264	Average		
2483.5	51.49	56.34	-4.85	74	-22.51	123	264	Peak		
4960	36.25	50.14	-13.89	54	-17.75	105	163	Average		
4960	44.66	58.55	-13.89	74	-29.34	105	163	Peak		
		Antenn	a Polarity &	Test Dista	nce: Vertica	l at 3 m				
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark		
2480	97.23	102.08	-4.85			136	87	Average		
2480	100.18	105.03	-4.85			136	87	Peak		
2483.5	47.4	52.25	-4.85	54	-6.6	136	87	Average		
2483.5	50.41	55.26	-4.85	74	-23.59	136	87	Peak		
4960	37.15	51.04	-13.89	54	-16.85	111	294	Average		
4960	44.1	57.99	-13.89	74	-29.9	111	294	Peak		

Remarks:

 Emission Level = Read Level + Factor Margin value = Emission level – Limit value

2. 2480 MHz: Fundamental frequency.

3. The emission levels of other frequencies were very low against the limit.



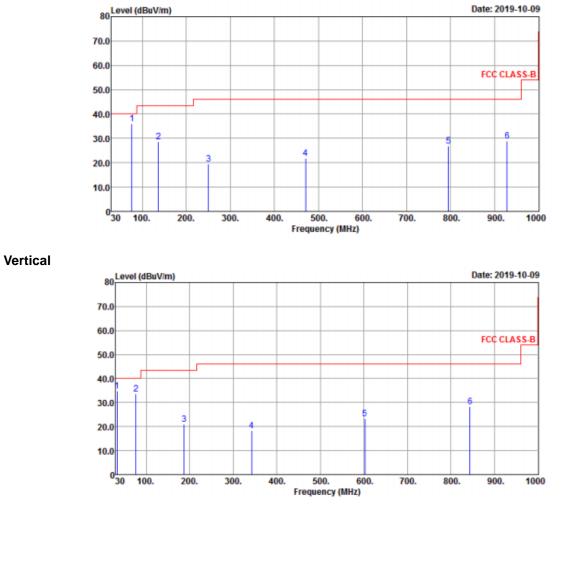
9 kHz ~ 30 MHz Data:

The amplitude of spurious emissions attenuated more than 20 dB below the permissible value is not required to be report.

30 MHz ~ 1 GHz Worst-Case Data:

EUT Test Condition		Measurement Detail		
Channel	Channel 78	Frequency Range	30 MHz ~ 1 GHz	
Input Power	120 Vac, 60 Hz	Detector Function	Peak (PK) Quasi-peak (QP)	
Environmental Conditions	25 deg. C, 65 % RH	Tested By	Tim Chen	

Horizontal





Antenna Polarity & Test Distance: Horizontal at 3 m								
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
76.56	36.04	57.12	-21.08	40	-3.96	129	36	Peak
136.7	28.54	46.66	-18.12	43.5	-14.96	114	35	Peak
250.19	19.58	37.18	-17.6	46	-26.42	127	350	Peak
470.38	21.99	34.22	-12.23	46	-24.01	100	184	Peak
795.33	26.9	31.95	-5.05	46	-19.1	134	5	Peak
928.22	28.85	31.8	-2.95	46	-17.15	126	60	Peak
		Antenna	a Polarity 8	Test Dista	nce: Vertica	l at 3 m		
Frequency (MHz)	Emission Level (dBuV/m)	Read Level (dBuV)	Factor (dB/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)	Remark
33.88	34.9	51.85	-16.95	40	-5.1	129	212	Peak
76.56	33.78	54.86	-21.08	40	-6.22	127	294	Peak
187.14	21.02	40.13	-19.11	43.5	-22.48	115	197	Peak
342.34	18.24	33.13	-14.89	46	-27.76	103	194	Peak
602.3	23.22	31.52	-8.3	46	-22.78	131	40	Peak
843.83	28.39	32.59	-4.2	46	-17.61	139	178	Peak

Remarks:

1. Emission Level = Read Level + Factor

Margin value = Emission level – Limit value

2. The emission levels of other frequencies were very low against the limit.



4.2 Conducted Emission Measurement

4.2.1 Limits of Conducted Emission Measurement

	Conducted Limit (dBuV)				
Frequency (MHz)	Quasi-Peak	Average			
0.15 - 0.5	66 - 56	56 - 46			
0.50 - 5.0	56	46			
5.0 - 30.0	60	50			

Note: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

4.2.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Date of Calibration	Due Date of Calibration
Test Receiver ROHDE & SCHWARZ	ESCI	100613	Dec. 10, 2018	Dec. 09, 2019
RF signal cable Woken	5D-FB	Cable-cond1-01	Sep. 05, 2019	Sep. 04, 2020
LISN ROHDE & SCHWARZ (EUT)	ENV216	101826	Feb. 21, 2019	Feb. 20, 2020
LISN ROHDE & SCHWARZ (Peripheral)	ESH3-Z5	100311	Aug. 22, 2019	Aug. 21, 2020
Software ADT	BV ADT_Cond_ V7.3.7.4	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Shielded Room 1.

3. The VCCI Site Registration No. is C-12040.



4.2.3 Test Procedures

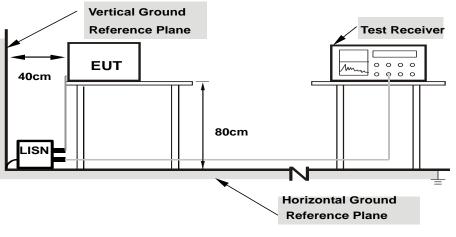
- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/ 50 uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit 20 dB) was not recorded.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz - 30 MHz.

4.2.4 Deviation from Test Standard

No deviation.

4.2.5 Test Setup



Note: 1.Support units were connected to second LISN. 2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.2.6 EUT Operating Condition

Set the EUT under transmission condition continuously at specific channel frequency.



4.2.7 Test Results

CONDUCTED WORST-CASE DATA : 8DPSK

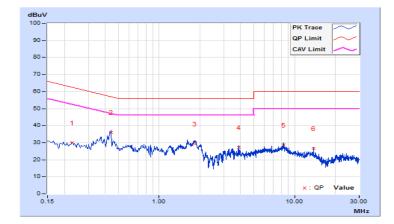
Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	120Vac, 60Hz	Environmental Conditions	25℃, 65%RH
Tested by	Getaz Yang	Test Date	2019/10/9

	Phase Of Power : Line (L)									
	Frequency	Correction	Readin	g Value	Emissic	on Level	Lir	nit	Mai	gin
No		Factor	(dB	uV)	(dB	uV)	(dB	uV)	(d	B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.22731	9.66	20.39	10.48	30.05	20.14	62.55	52.55	-32.50	-32.41
2	0.44273	9.69	26.19	13.89	35.88	23.58	57.01	47.01	-21.13	-23.43
3	1.82719	9.77	19.68	8.58	29.45	18.35	56.00	46.00	-26.55	-27.65
4	3.85668	9.84	17.53	6.64	27.37	16.48	56.00	46.00	-28.63	-29.52
5	8.32972	9.90	18.65	8.08	28.55	17.98	60.00	50.00	-31.45	-32.02
6	13.81545	9.96	16.48	4.47	26.44	14.43	60.00	50.00	-33.56	-35.57

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss

5. Emission Level = Correction Factor + Reading Value





Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	120Vac, 60Hz	Environmental Conditions	25℃, 65%RH
Tested by	Getaz Yang	Test Date	2019/10/9

	Phase Of Power : Neutral (N)									
	Frequency	Correction	Readin	g Value	Emissic	on Level	Lir	nit	Ma	rgin
No		Factor	(dB	uV)	(dB	uV)	(dB	uV)	(d	B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.16181	9.64	25.95	5.30	35.59	14.94	65.37	55.37	-29.78	-40.43
2	0.24775	9.64	22.58	10.39	32.22	20.03	61.83	51.83	-29.61	-31.80
3	0.41560	9.66	29.23	17.80	38.89	27.46	57.54	47.54	-18.65	-20.08
4	1.88213	9.74	22.83	7.21	32.57	16.95	56.00	46.00	-23.43	-29.05
5	4.24377	9.81	15.02	1.91	24.83	11.72	56.00	46.00	-31.17	-34.28
6	7.59464	9.87	20.18	8.29	30.05	18.16	60.00	50.00	-29.95	-31.84

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

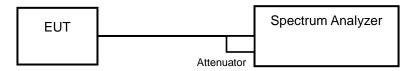


4.3 Number of Hopping Frequency Used

4.3.1 Limits of Hopping Frequency Used Measurement

At least 15 channels frequencies, and should be equally spaced.

4.3.2 Test Setup



4.3.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.3.4 Test Procedure

- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Set the SA on MaxHold Mode, and then keep the EUT in hopping mode. Record all the signals from each channel until each one has been recorded.
- d. Set the SA on View mode and then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

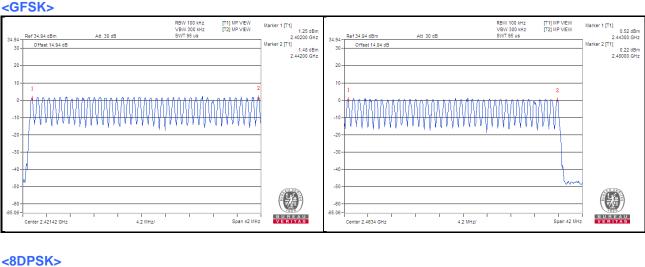
4.3.5 Deviation from Test Standard

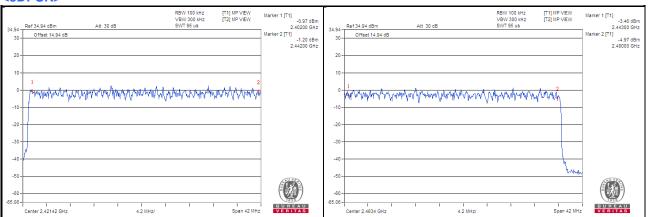
No deviation.



4.3.6 Test Results

There are 79 hopping frequencies in the hopping mode. Please refer to next page for the test result. On the plots, it shows that the hopping frequencies are equally spaced.





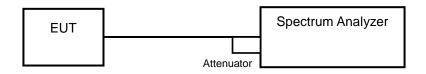


4.4 Dwell Time on Each Channel

4.4.1 Limits of Dwell Time on Each Channel Measurement

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

4.4.2 Test Setup



4.4.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.4.4 Test Procedures

- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Adjust the center frequency of SA on any frequency be measured and set SA to zero span mode. And then, set RBW and VBW of spectrum analyzer to proper value.
- d. Measure the time duration of one transmission on the measured frequency. And then plot the result with time difference of this time duration.
- e. Repeat above procedures until all different time-slot modes have been completed.
- 4.4.5 Deviation from Test Standard

No deviation.

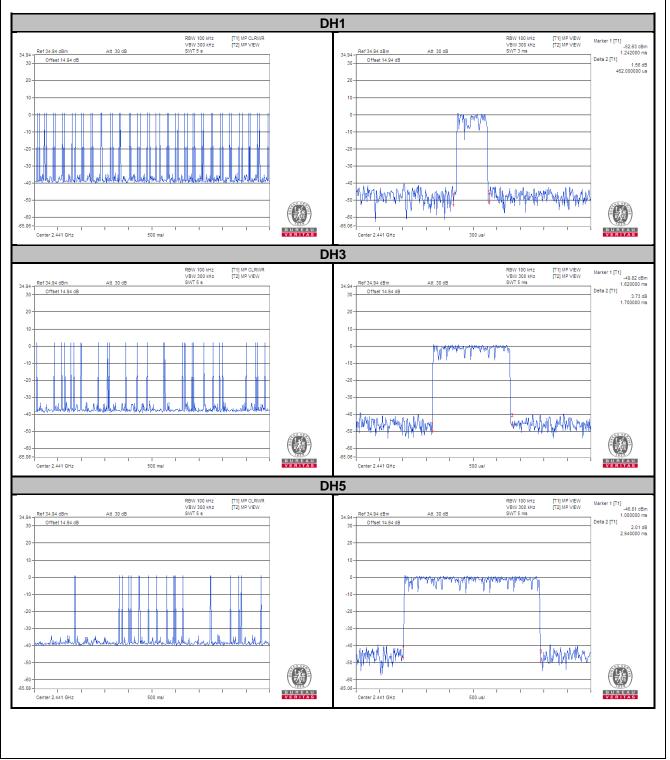


4.4.6 Test Results

GFSK

Mode	Number of Transmission in a 31.6 (79 Hopping*0.4)	Length of Transmission Time (msec)	Result (msec)	Limit (msec)
DH1	50 (times / 5 sec) * 6.32 = 316 times	0.462	145.99	400
DH3	27 (times / 5 sec) * 6.32 = 170.64 times	1.7	290.09	400
DH5	17 (times / 5 sec) * 6.32 = 107.44 times	2.94	315.87	400

Note: Test plots of the transmitting time slot are shown as below.

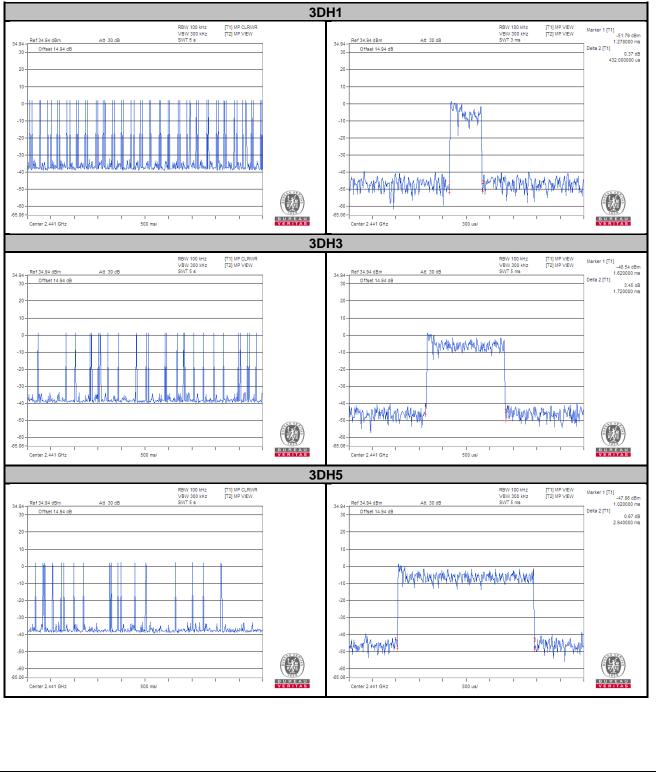




8DPSK

Mode	Number of Transmission in a 31.6 (79 Hopping*0.4)	Length of Transmission Time (msec)	Result (msec)	Limit (msec)
3DH1	51 (times / 5 sec) * 6.32 = 322.32 times	0.432	139.24	400
3DH3	26 (times / 5 sec) * 6.32 = 164.32 times	1.72	282.63	400
3DH5	18 (times / 5 sec) * 6.32 = 113.76 times	2.94	334.45	400

Note: Test plots of the transmitting time slot are shown as below.



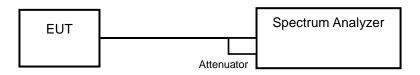


4.5 Channel Bandwidth

4.5.1 Limits of Channel Bandwidth Measurement

For frequency hopping system operating in the 2400-2483.5 MHz, if the 20 dB bandwidth of hopping channel is greater than 25 kHz, two-thirds 20 dB bandwidth of hopping channel shell be a minimum limit for the hopping channel separation.

4.5.2 Test Setup



4.5.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.5.4 Test Procedure

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- c. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
- d. Repeat above procedures until all frequencies measured were complete.

4.5.5 Deviation from Test Standard

No deviation.

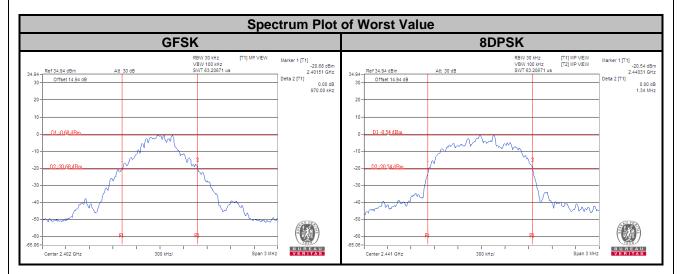
4.5.6 EUT Operating Condition

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.



4.5.7 Test Results

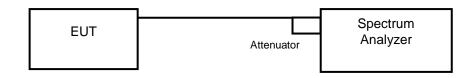
Channal	Frequency	20 dB Bandwidth (MHz)				
Channel	(MHz)	GFSK	8DPSK			
0	2402	0.97	1.33			
39	2441	0.97	1.34			
78	2480	0.97	1.34			





4.6 Occupied Bandwidth Measurement

4.6.1 Test Setup



4.6.2 Test Instruments

Refer to section 4.1.2 to get information of above instrument

4.6.3 Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with resolution bandwidth in the range of 1 % to 5 % of the anticipated emission bandwidth, and a video bandwidth at least 3x the resolution bandwidth and set the detector to PEAK. The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.

4.6.4 Deviation from Test Standard

No deviation.

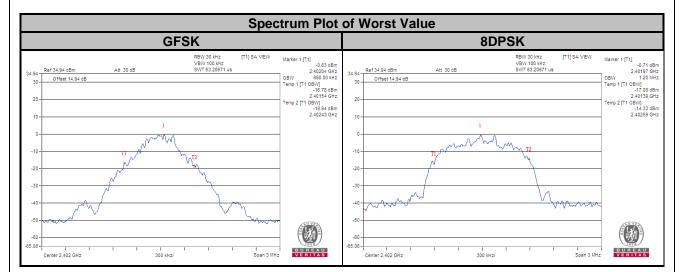
4.6.5 EUT Operating Conditions

The software provided by client to enable the EUT under transmission condition continuously at lowest, middle and highest channel frequencies individually.



4.6.6 Test Results

Channel	Frequency	Occupied Bandwidth (MHz)				
Channel	(MHz)	GFSK	8DPSK			
0	2402	0.89	1.20			
39	2441	0.89	1.20			
78	2480	0.88	1.20			



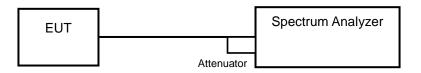


4.7 Hopping Channel Separation

4.7.1 Limits of Hopping Channel Separation Measurement

At least 25 kHz or two-third of 20 dB hopping channel bandwidth (whichever is greater).

4.7.2 Test Setup



4.7.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.7.4 Test Procedure

Measurement Procedure REF

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range.
- c. By using the MaxHold function record the separation of two adjacent channels.
- d. Measure the frequency difference of these two adjacent channels by SA MARK function. And then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

4.7.5 Deviation from Test Standard

No deviation.

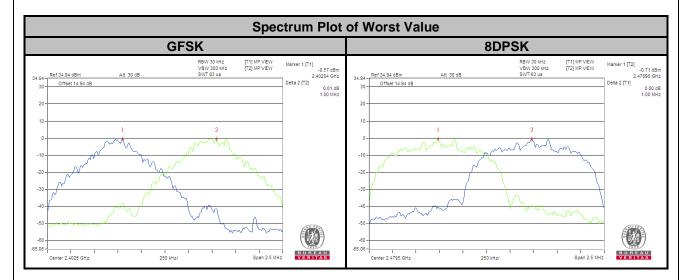


4.7.6 Test Results

Channel	Freq. (MHz)	Adjacent Separ (MI		20 Bandwid	dB lth (MHz)	Minimum Limit (MHz)		Pass / Fail	
		GFSK	8DPSK	GFSK	8DPSK	GFSK	8DPSK		
0	2402	1.00	1.00	0.97	1.33	0.65	0.89	Pass	
39	2441	1.00	1.00	0.97	1.34	0.65	0.90	Pass	
78	2480	1.00	1.00	0.97	1.34	0.65	0.90	Pass	

Note:

1. The minimum limit is two-third 20 dB bandwidth.



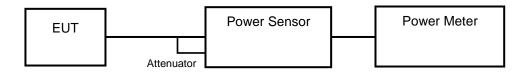


4.8 Maximum Output Power

4.8.1 Limits of Maximum Output Power Measurement

Refer to Regulation 15.247 (b)(1), the Maximum Output Power Measurement is 125 mW.

4.8.2 Test Setup



4.8.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.8.4 Test Procedure

A peak power sensor was used on the output port of the EUT. A power meter was used to read the response of the peak power sensor. Record the power level.

4.8.5 Deviation from Test Standard

No deviation.

4.8.6 EUT Operating Condition

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.

4.8.7 Test Results

<GFSK>

Channel	Freq. (MHz)	Peak Power (mW)	Peak Power (dBm)	Power Limit (mW)	Pass / Fail
0	2402	2.999	4.77	125	Pass
39	2441	2.944	4.69	125	Pass
78	2480	2.944	4.69	125	Pass

<8DPSK>

Channel	Freq. (MHz)	Peak Power (mW)	Peak Power (dBm)	Power Limit (mW)	Pass / Fail
0	2402	4.477	6.51	125	Pass
39	2441	4.266	6.30	125	Pass
78	2480	4.487	6.52	125	Pass



4.9 Conducted Out of Band Emission Measurement

4.9.1 Limits Of Conducted Out of Band Emission Measurement

Below –20 dB of the highest emission level of operating band (in 100 kHz RBW).

4.9.2 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.9.3 Test Procedure

The transmitter output was connected to the spectrum analyzer via a low lose cable. Set both RBW and VBW of spectrum analyzer to 100 kHz and 300 kHz with suitable frequency span including 100 MHz bandwidth from band edge. The band edges was measured and recorded.

4.9.4 Deviation from Test Standard

No deviation.

4.9.5 EUT Operating Condition

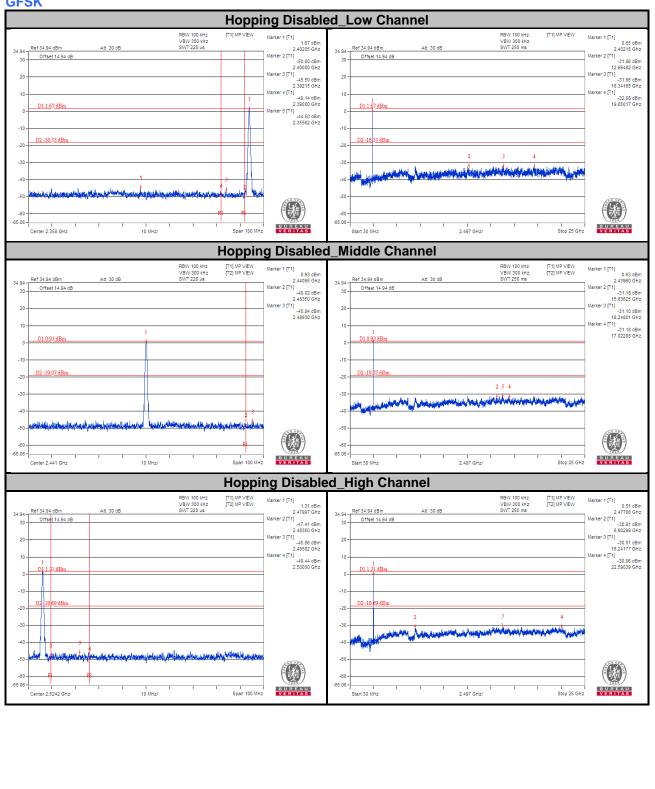
The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.

4.9.6 Test Results

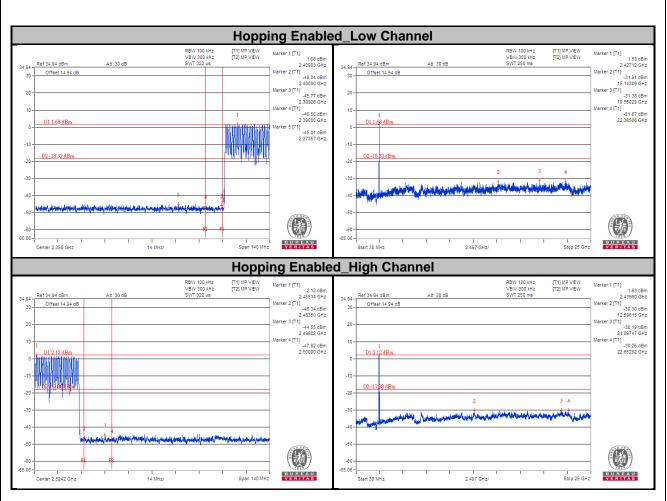
The spectrum plots are attached on the following images. D1 line indicates the highest level, D2 line indicates the 20 dB offset below D1. It shows compliance with the requirement.





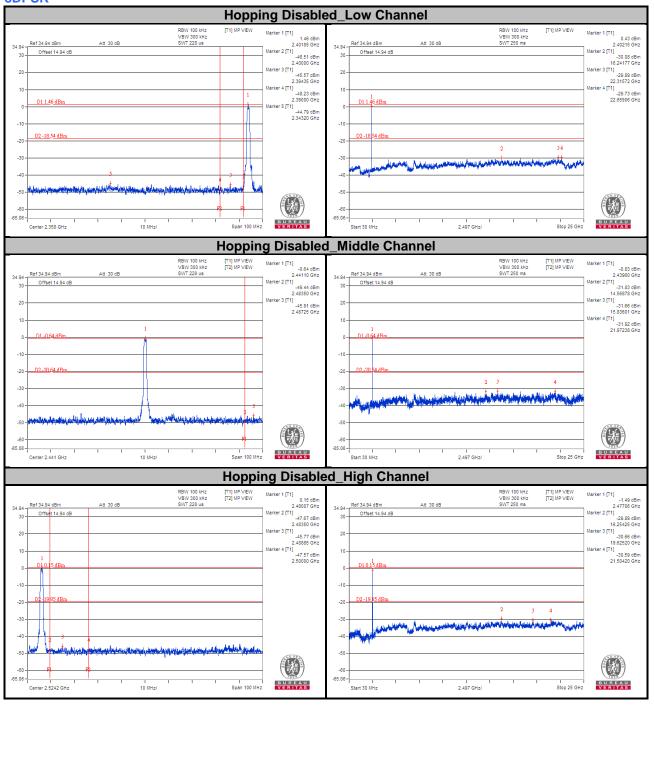




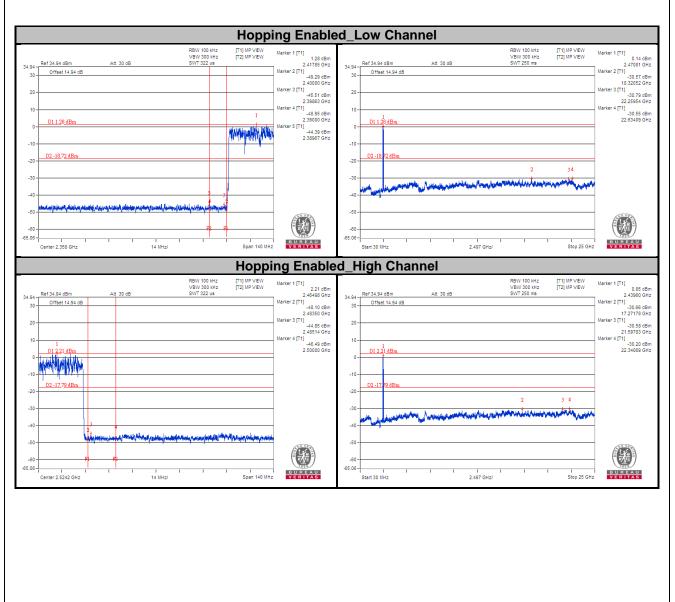




8DPSK









5 Pictures of Test Arrangements

Please refer to the attached file (Test Setup Photo).



Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are FCC recognized accredited test firms and accredited according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

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The address and road map of all our labs can be found in our web site also.

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